TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (L^2 - π -MOSV)

2SK2311

Chopper Regulator, DC-DC Converter and Switching Regulator Applications

• 4-V gate drive

 $\begin{array}{ll} \bullet & \text{Low drain-source ON resistance} & : R_{DS} \text{ (ON)} = 36 \text{ m}\Omega \text{ (typ.)} \\ \bullet & \text{High forward transfer admittance} & : |Y_{fs}| = 16 \text{ S (typ.)} \\ \end{array}$

• Low leakage current : $IDSS = 100 \mu A (max) (VDS = 60 V)$

• Enhancement mode : $V_{th} = 0.8 \sim 2.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	60	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	60	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	ΙD	25	Α	
	Pulse (Note 1)	I _{DP}	100	Α	
Drain power dissipation (Tc = 25°C)		P _D	40	W	
Single pulse avalanche energy (Note 2)		E _{AS}	156	mJ	
Avalanche current		I _{AR}	25	Α	
Repetitive avalanche energy (Note 3)		E _{AR}	3.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	3.125	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	83.3	°C/W

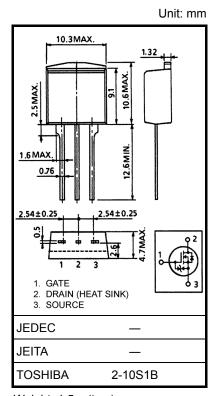
Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: V_{DD} = 25 V, T_{ch} = 25°C (initial), L = 339 μ H, R_{G} = 25 Ω , I_{AR} = 25 A

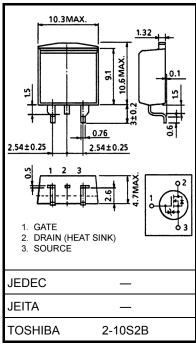
Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device.

Please handle with caution.



Weight: 1.5 g (typ.)



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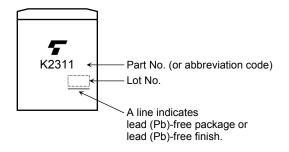
Electrical Characteristics (Ta = 25°C)

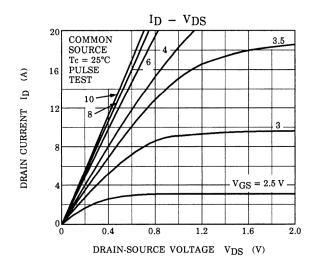
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V	_	_	100	μA
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	60	_	_	V
Gate threshold v	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	0.8	_	2.0	V
Drain-source ON resistance		R _{DS (ON)}	V _{GS} = 4 V, I _D = 12 A	-	57	80	mΩ
			V _{GS} = 10 V, I _D = 12 A	_	36	46	11117
Forward transfer	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 12 A	10	16	_	S
Input capacitano	e	C _{iss}		_	1000	_	
Reverse transfe	r capacitance	C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		200	_	pF
Output capacitance		Coss			550	_	
Switching time	Rise time	t _r	$V_{GS} \stackrel{10 \text{ V}}{\circ} V \stackrel{\text{I}_{D} = 12 \text{ A}}{\circ} V_{OUT}$ $R_{L} = 2.5 \Omega$ $V_{DD} = 30 \text{ V}$	_	20	_	
	Turn-on time	t _{on}		_	30	_	no
	Fall time	t _f		_	55	_	ns
	Turn-off time	toff	Duty $\leq 1\%$, $t_{\mathbf{w}} = 10 \ \mu s$	_	130	_	
Total gate charge (Gate-source plus gate-drain)		Qg		_	38	_	
Gate-source charge		Q _{gs}	$V_{DD} \approx 48 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 25 \text{ A}$		25	_	nC
Gate-drain ("miller") charge		Q _{gd}			13	_	

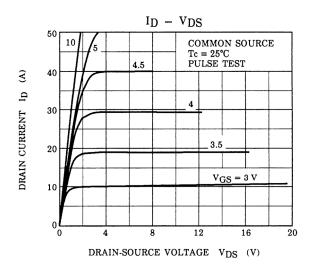
Source-Drain Ratings and Characteristics (Ta = 25°C)

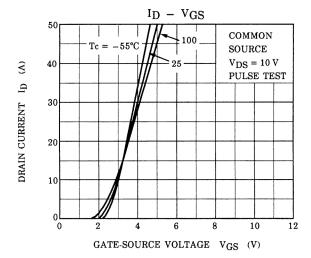
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	25	Α
Pulse drain reverse current (Note 1)	I _{DRP}	-	_	_	100	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = 25 A, V _{GS} = 0 V	_	_	-1.8	V
Reverse recovery time	t _{rr}	I _{DR} = 25 A, V _{GS} = 0 V		50	_	ns
Reverse recovery charge	Qrr	dI _{DR} / dt = 50 A / μs	_	35	_	μC

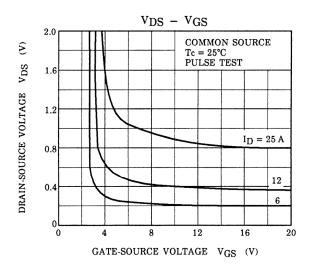
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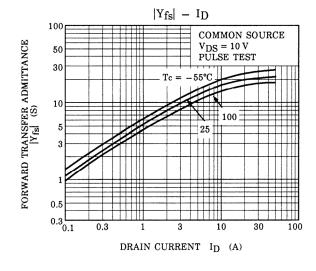


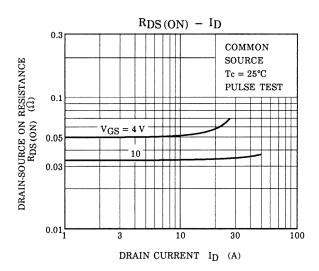


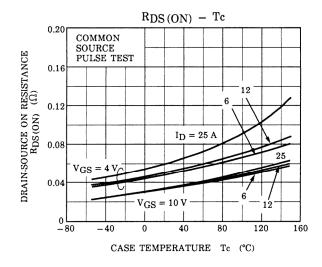


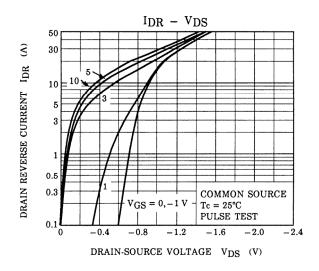


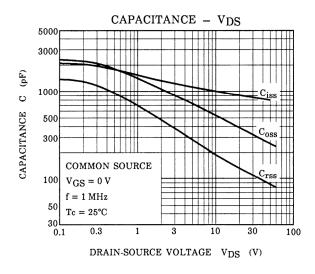


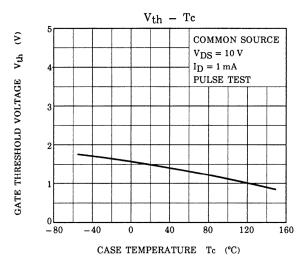


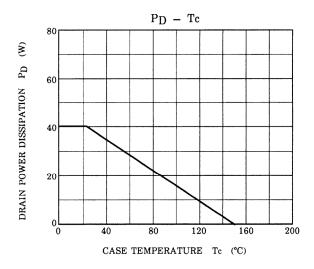


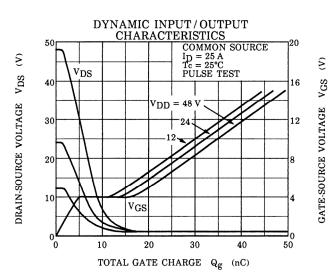


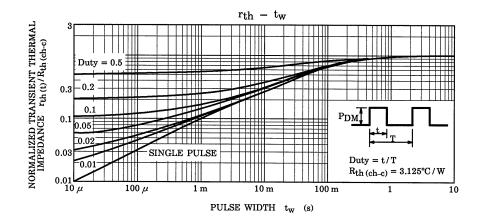


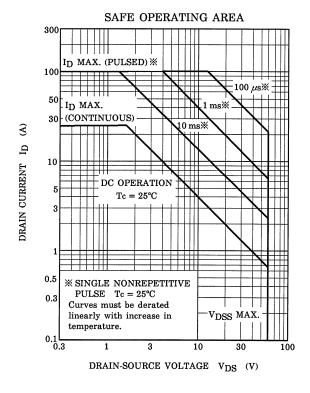


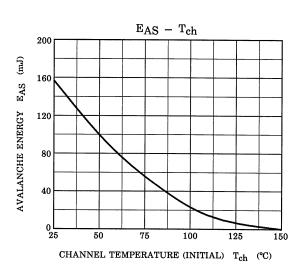


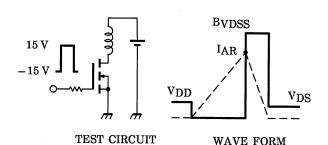












 R_{G} = 25 Ω V_{DD} = 25 V, L = 339 μ H IT WAVE FORM $EAS = \frac{1}{2} \cdot L \cdot I^{2} \cdot \left(\frac{BVDSS}{BVDSS - VDD} \right)$

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